

# P-Channel 20 V (D-S) MOSFET



Marking code: BQ

PRODUCT SUMMARY					
V <sub>DS</sub> (V)	-20				
$R_{DS(on)}$ max. ( $\Omega$ ) at $V_{GS} = -4.5 \text{ V}$	0.041				
$R_{DS(on)}$ max. ( $\Omega$ ) at $V_{GS} = -2.5 \text{ V}$	0.054				
$R_{DS(on)}$ max. ( $\Omega$ ) at $V_{GS} = -1.8 \text{ V}$	0.100				
Q <sub>g</sub> typ. (nC)	12.5				
I <sub>D</sub> (A) <sup>a</sup>	-4				
Configuration	Single				

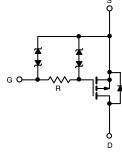
### **FEATURES**

- TrenchFET® power MOSFET
- Typical ESD performance 1500 V
- 100 % R<sub>q</sub> tested
- Material categorization: for definitions of compliance please see www.vishay.com/doc?99912



## **APPLICATIONS**

- · Load switch for portable devices
  - Cellular phone
  - DSC
  - Portable game console
  - MP3
  - GPS



P-Channel MOSFET

ORDERING INFORMATION		
Package	SC-70	
Lead (Pb)-free and halogen-free	Si1441EDH-T1-GE3	

PARAMETER		SYMBOL	LIMIT	UNIT
Drain-source voltage		V <sub>DS</sub>	-20	.,
Gate-source voltage		V <sub>GS</sub>	± 10	
	T <sub>C</sub> = 25 °C		-4 a	
Continuous dunin comment (T. 150 °C)	T <sub>C</sub> = 70 °C	1 .	-4	
Continuous drain current (T <sub>J</sub> = 150 °C)	T <sub>A</sub> = 25 °C	I <sub>D</sub>	_4 a, b, c	
	T <sub>A</sub> = 70 °C		_4 a, b, c	Α
Pulsed drain current (t = 300 μs)	I <sub>DM</sub>	-25		
Continuous source-drain diode current	T <sub>C</sub> = 25 °C	1	-2.3	
	T <sub>A</sub> = 25 °C	l <sub>S</sub> –	-1.3 <sup>b, c</sup>	
	T <sub>C</sub> = 25 °C		2.8	
Maximum power dissipation	T <sub>C</sub> = 70 °C		1.8	10/
	T <sub>A</sub> = 25 °C	P <sub>D</sub>	1.6 <sup>b, c</sup>	– w
	T <sub>A</sub> = 70 °C		1 b, c	
Operating junction and storage temperature range		T <sub>J</sub> , T <sub>stg</sub>	-55 to +150	°C
Soldering recommendations (peak temperature		260	-0	

THERMAL RESISTANCE RATINGS						
PARAMETER		SYMBOL	TYPICAL	MAXIMUM	UNIT	
Maximum junction-to-ambient b, d	t ≤ 5 s	R <sub>thJA</sub>	60	80	°C/W	
Maximum junction-to-foot (drain)	Steady state	$R_{thJF}$	34	45	C/VV	

- a. Package limited
- b. Surface mounted on 1" x 1" FR4 board
- c. t = 5 sd. Maximum under steady state conditions is 125 °C/W



PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT	
Static	·						
Drain-source breakdown voltage	V <sub>DS</sub>	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$	-20	-	-	V	
V <sub>DS</sub> temperature coefficient	$\Delta V_{DS}/T_{J}$	J 250 A	-	-11	-	mV/°C	
V <sub>GS(th)</sub> temperature coefficient	$\Delta V_{GS(th)}/T_J$	$I_D = -250  \mu A$	-	2.6	-		
Gate-source threshold voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	-0.4	-	-1	V	
Gate-source leakage	1	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 10 \text{ V}$	-	-	± 8		
Gate-source leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 4.5 \text{ V}$	-	-	± 1	μA	
Zero gate voltage drain current	l- aa	$V_{DS} = -20 \text{ V}, V_{GS} = 0 \text{ V}$	-	-	-1	μΑ	
Zero gate voltage drain current	I <sub>DSS</sub>	$V_{DS}$ = -20 V, $V_{GS}$ = 0 V, $T_J$ = 55 °C	-	-	-10		
On-state drain current a	I <sub>D(on)</sub>	$V_{DS} \le$ -5 V, $V_{GS} =$ -10 V	-15	-	-	Α	
		$V_{GS} = -4.5 \text{ V}, I_D = -5 \text{ A}$	-	0.034	0.041		
Drain-source on-state resistance a	R <sub>DS(on)</sub>	$V_{GS} = -2.5 \text{ V}, I_D = -4.4 \text{ A}$	-	0.045	0.054	Ω	
		$V_{GS} = -1.8 \text{ V}, I_D = -1 \text{ A}$	-	0.067	0.100		
Forward transconductance a	9 <sub>fs</sub>	$V_{DS} = -10 \text{ V}, I_{D} = -5 \text{ A}$	-	16	-	S	
Dynamic <sup>b</sup>							
Total gate charge	Qg	$V_{DS} = -10 \text{ V}, V_{GS} = -8 \text{ V}, I_D = -5 \text{ A}$	-	22	33	- nC	
			-	12.5	19		
Gate-source charge	$Q_{gs}$	$V_{DS}$ = -10 V, $V_{GS}$ = -4.5 V, $I_D$ = -5 A	-	1.8	-		
Gate-drain charge	$Q_{gd}$		-	3.3	-		
Gate resistance	$R_g$	f = 1 MHz	80	430	860	Ω	
Turn-on delay time	t <sub>d(on)</sub>		-	150	225		
Rise time	t <sub>r</sub>	$V_{DD}$ = -10 V, $R_L$ = 1.4 $\Omega$	-	300	450		
Turn-off delay time	t <sub>d(off)</sub>	$I_D \cong -4 \text{ A}, V_{GEN} = -4.5 \text{ V}, R_g = 1 \Omega$	-	1620	2430		
Fall time	t <sub>f</sub>		-	560	840	ne	
Turn-on delay time	t <sub>d(on)</sub>		-	50	100	ns	
Rise time	t <sub>r</sub>	$V_{DD}$ = -10 V, $R_L$ = 1.4 $\Omega$	-	90	180		
Turn-off delay time	t <sub>d(off)</sub>	$I_D\cong$ -4 A, $V_{GEN}=$ -10 V, $R_g=$ 1 $\Omega$	-	2500	3750		
Fall time	t <sub>f</sub>		-	600	900	<u> </u>	
<b>Drain-Source Body Diode Characteris</b>	tics						
Continuous source-drain diode current	I <sub>S</sub>	$T_C = 25  ^{\circ}C$	-	-	-2.3	А	
Pulse diode forward current	I <sub>SM</sub>		-	-	-25		
Body diode voltage	$V_{SD}$	$I_S = -4 \text{ A}, V_{GS} = 0 \text{ V}$	-	-0.85	-1.2	V	
Body diode reverse recovery time	t <sub>rr</sub>		-	18	36	ns	
Body diode reverse recovery charge	Q <sub>rr</sub>	$I_F = -4 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s},$	-	8	16	nC	
Reverse recovery fall time t <sub>a</sub>		T <sub>J</sub> = 25 °C	-	18	-	no	
Reverse recovery rise time	rse recovery rise time t <sub>b</sub>		-	10	-	ns	

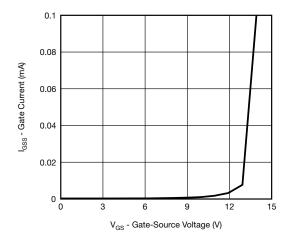
#### Notes

- a. Pulse test; pulse width  $\leq$  300  $\mu$ s, duty cycle  $\leq$  2 %
- b. Guaranteed by design, not subject to production testing

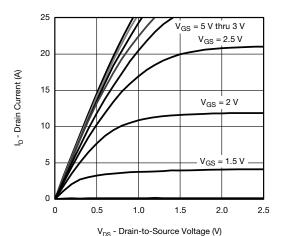
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



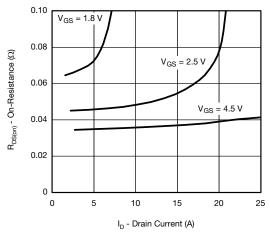
# TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



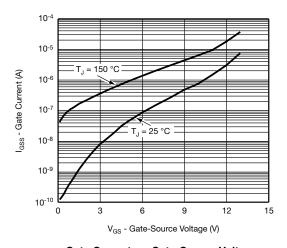
## Gate Current vs. Gate-Source Voltage



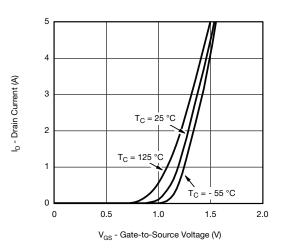
**Output Characteristics** 



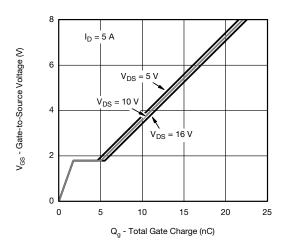
On-Resistance vs. Drain Current



Gate Current vs. Gate-Source Voltage



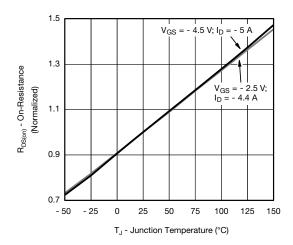
**Transfer Characteristics** 



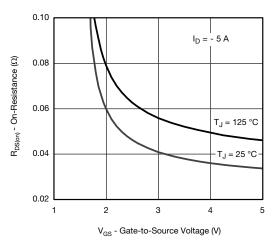
**Gate Charge** 



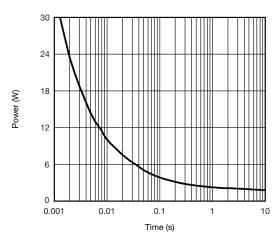
# TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



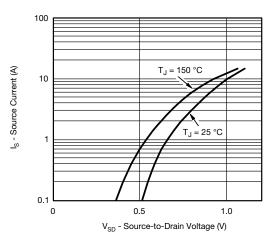
### On-Resistance vs. Junction Temperature



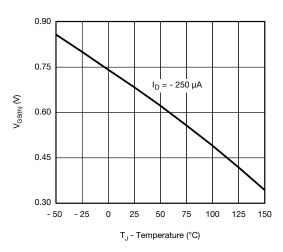
# On-Resistance vs. Gate-to-Source Voltage



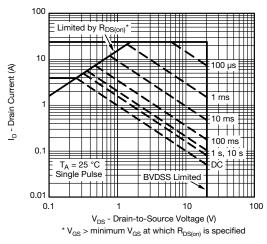
**Threshold Voltage** 



### Source-Drain Diode Forward Voltage

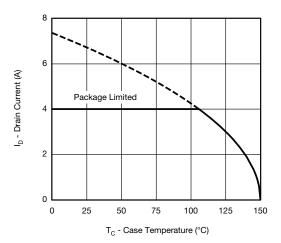


# Single Pulse Power, Junction-to-Ambient

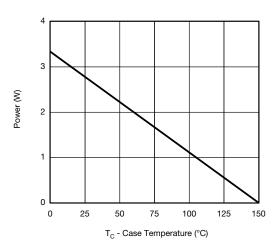


Safe Operating Area, Junction-to-Ambient

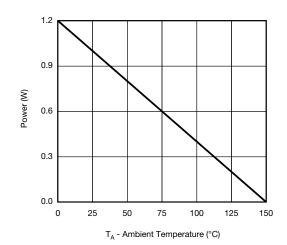
# TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



## Current Derating a







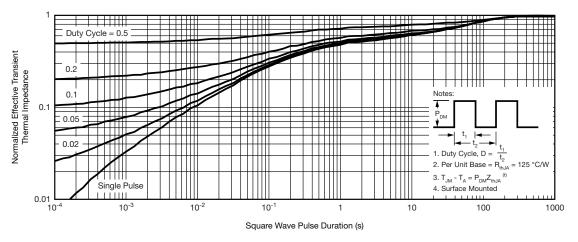
Power Derating, Junction-to-Ambient

# Note

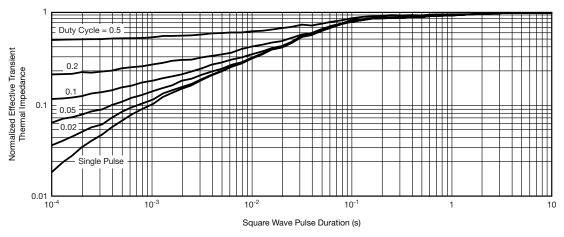
a. The power dissipation P<sub>D</sub> is based on T<sub>J</sub> max. = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit



# TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Foot

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# SC-70: 6-LEADS





	MILLIMETERS INCH			NCHE	ES	
Dim	Min	Nom	Max	Min	Nom	Max
Α	0.90	-	1.10	0.035	_	0.043
A <sub>1</sub>	-	-	0.10	-	-	0.004
$A_2$	0.80	-	1.00	0.031	-	0.039
b	0.15	-	0.30	0.006	_	0.012
С	0.10	-	0.25	0.004	_	0.010
D	1.80	2.00	2.20	0.071	0.079	0.087
Ε	1.80	2.10	2.40	0.071	0.083	0.094
E <sub>1</sub>	1.15	1.25	1.35	0.045	0.049	0.053
е		0.65BSC			0.026BSC	;
e <sub>1</sub>	1.20	1.30	1.40	0.047	0.051	0.055
L	0.10	0.20	0.30	0.004	0.008	0.012
9		7°Nom			7°Nom	





# Single-Channel LITTLE FOOT® SC-70 6-Pin MOSFET Copper Leadframe Version Recommended Pad Pattern and Thermal Performance

### INTRODUCTION

The new single 6-pin SC-70 package with a copper leadframe enables improved on-resistance values and enhanced thermal performance as compared to the existing 3-pin and 6-pin packages with Alloy 42 leadframes. These devices are intended for small to medium load applications where a miniaturized package is required. Devices in this package come in a range of on-resistance values, in n-channel and p-channel versions. This technical note discusses pin-outs, package outlines, pad patterns, evaluation board layout, and thermal performance for the single-channel version.

### **BASIC PAD PATTERNS**

See Application Note 826, Recommended Minimum Pad Patterns With Outline Drawing Access for Vishay Siliconix MOSFETs, (http://www.vishay.com/doc?72286) for the basic pad layout and dimensions. These pad patterns are sufficient for the low to medium power applications for which this package is intended. Increasing the drain pad pattern yields a reduction in thermal resistance and is a preferred footprint. The availability of four drain leads rather than the traditional single drain lead allows a better thermal path from the package to the PCB and external environment.

### **PIN-OUT**

Figure 1 shows the pin-out description and Pin 1 identification. The pin-out of this device allows the use of four pins as drain leads, which helps to reduce on-resistance and junction-to-ambient thermal resistance.

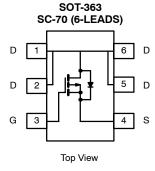


FIGURE 1.

For package dimensions see outline drawing SC-70 (6-Leads) (http://www.vishay.com/doc?71154)

### **EVALUATION BOARDS — SINGLE SC70-6**

The evaluation board (EVB) measures 0.6 inches by 0.5 inches. The copper pad traces are the same as in Figure 2. The board allows examination from the outer pins to 6-pin DIP connections, permitting test sockets to be used in evaluation testing. See Figure 3.

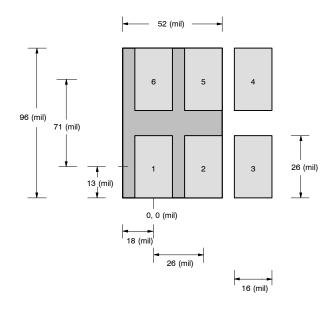
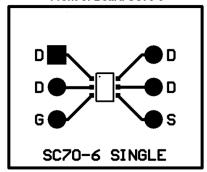


FIGURE 2. SC-70 (6 leads) Single

The thermal performance of the single 6-pin SC-70 has been measured on the EVB, comparing both the copper and Alloy 42 leadframes. This test was first conducted on the traditional Alloy 42 leadframe and was then repeated using the 1-inch<sup>2</sup> PCB with dual-side copper coating.



Front of Board SC70-6



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Back of Board SC70-6

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FIGURE 3.

### THERMAL PERFORMANCE

# **Junction-to-Foot Thermal Resistance** (Package Performance)

The junction to foot thermal resistance is a useful method of comparing different packages thermal performance.

A helpful way of presenting the thermal performance of the 6-Pin SC-70 copper leadframe device is to compare it to the traditional Alloy 42 version.

Thermal performance for the 6-pin SC-70 measured as junction-to-foot thermal resistance, where the "foot" is the drain lead of the device at the bottom where it meets the PCB. The junction-to-foot thermal resistance is typically 40°C/W in the copper leadframe and 163°C/W in the Alloy 42 leadframe - a four-fold improvement. This improved performance is obtained by the enhanced thermal conductivity of copper over Alloy 42.

# **Power Dissipation**

The typical  $R\theta_{JA}$  for the single 6-pin SC-70 with copper leadframe is 103°C/W steady-state, compared with 212°C/W for the Alloy 42 version. The figures are based on the 1-inch<sup>2</sup> FR4 test board. The following example shows how the thermal resistance impacts power dissipation for the two different leadframes at varying ambient temperatures.

ALLOY 42 LEADFRAME				
Room Ambient 25 °C	Elevated Ambient 60 °C			
$P_D = \frac{T_{J(max)} - T_A}{R\theta_{JA}}$	$P_D = \frac{T_{J(max)} - T_A}{R\theta_{JA}}$			
$P_{D} = \frac{150^{\circ}C - 25^{\circ}C}{212^{\circ}C/W}$	$P_{D} = \frac{150^{\circ}C - 25^{\circ}C}{212^{\circ}C/W}$			
$P_D = 590 \text{ mW}$	$P_D = 425 \text{ mW}$			

COOPER LEADFRAME				
Room Ambient 25 °C	Elevated Ambient 60 °C			
$P_{D} = \frac{T_{J(max)} - T_{A}}{R\theta_{JA}}$ $P_{D} = \frac{150^{\circ}C - 25^{\circ}C}{124^{\circ}C/W}$	$P_{D} = \frac{T_{J(max)} - T_{A}}{R\theta_{JA}}$ $P_{D} = \frac{150^{\circ}C - 60^{\circ}C}{124^{\circ}C/W}$			
$P_{D} = 1.01 \text{ W}$	P <sub>D</sub> = 726 mW			

As can be seen from the calculations above, the compact 6-pin SC-70 copper leadframe LITTLE FOOT power MOSFET can handle up to 1 W under the stated conditions.

# **Testing**

To further aid comparison of copper and Alloy 42 leadframes, Figure 5 illustrates single-channel 6-pin SC-70 thermal performance on two different board sizes and two different pad patterns. The measured steady-state values of  $R\theta_{JA}$  for the two leadframes are as follows:

LITTLE FOOT 6-PIN SC-70					
	Alloy 42	Copper			
1) Minimum recommended pad pattern on the EVB board V (see Figure 3.	329.7°C/W	208.5°C/W			
<ol> <li>Industry standard 1-inch<sup>2</sup> PCB with maximum copper both sides.</li> </ol>	211.8°C/W	103.5°C/W			

The results indicate that designers can reduce thermal resistance ( $R\theta_{1\Delta}$ ) by 36% simply by using the copper leadframe device rather than the Alloy 42 version. In this example, a 121°C/W reduction was achieved without an increase in board area. If increasing in board size is feasible, a further 105°C/W reduction could be obtained by utilizing a 1-inch<sup>2</sup> square PCB area.

The copper leadframe versions have the following suffix:

Single: Si14xxEDH Dual: Si19xxEDH Complementary: Si15xxEDH

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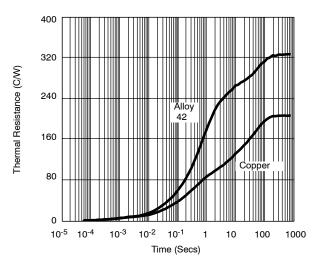


FIGURE 4. Leadframe Comparison on EVB

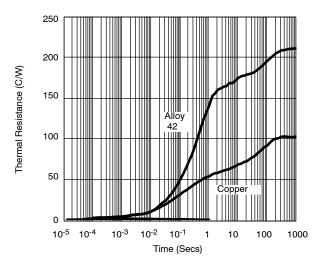


FIGURE 5. Leadframe Comparison on Alloy 42 1-inch<sup>2</sup> PCB



# **RECOMMENDED MINIMUM PADS FOR SC-70: 6-Lead**



Recommended Minimum Pads Dimensions in Inches/(mm)

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